

## **BUH315D**

# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- STMicroelectronics PREFERRED SALESTYPE
- HIGH VOLTAGE CAPABILITY
- U.L. RECOGNISED ISOWATT218 PACKAGE (U.L. FILE # E81734 (N))
- NPN TRANSISTOR WITH INTEGRATED FREEWHEELING DIODE.

#### **APPLICATIONS**

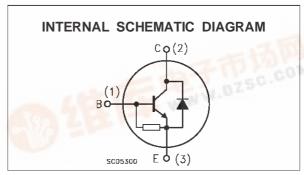
 HORIZONTAL DEFLECTION FOR COLOUR TV

#### **DESCRIPTION**

The BUH315D is manufactured using Multiepitaxial Mesa technology for cost-effective high performance and uses a Hollow Emitter structure to enhance switching speeds.

The BUH series is designed for use in horizontal deflection circuits in televisions and monitors.





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit	
V <sub>CBO</sub>	Collector-Base Voltage (I <sub>E</sub> = 0)	1500	V	
V <sub>CEO</sub>	Collector-Emitter Voltage (I <sub>B</sub> = 0)	700	V	
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	10	V	
Ic	Collector Current	6	А	
I <sub>CM</sub>	Collector Peak Current (tp < 5 ms)	12	А	
I <sub>B</sub>	Base Current	3	А	
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	5	А	
Ptot	Total Dissipation at T <sub>c</sub> = 25 °C	44	W	
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C	
Tj	Max. Operating Junction Temperature	150	°C	



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#### **BUH315D**

#### THERMAL DATA

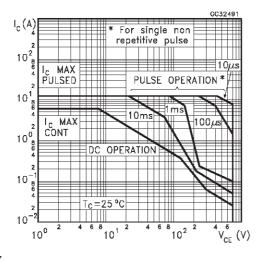
R <sub>thj-case</sub> Thermal Resistance Junction-case	Max	2.8	°C/W
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### **ELECTRICAL CHARACTERISTICS** (T<sub>case</sub> = 25 °C unless otherwise specified)

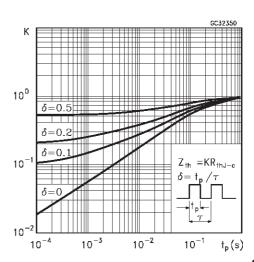
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>CES</sub>	Collector Cut-off Current (V <sub>BE</sub> = 0)	V <sub>CE</sub> = 1500 V			200	μА
I <sub>EBO</sub>	Emitter Cut-off Current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 5 V			300	mA
$V_{\text{CE}(\text{sat})^*}$	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 3 A I <sub>B</sub> = 1 A			1.5	V
V <sub>BE(sat)</sub> *	Base-Emitter Saturation Voltage	I <sub>C</sub> = 3 A I <sub>B</sub> = 1 A			1.5	V
h <sub>FE</sub> *	DC Current Gain	I <sub>C</sub> = 3 A V <sub>CE</sub> = 5 V I <sub>C</sub> = 3 A V <sub>CE</sub> = 5 V T <sub>j</sub> = 100 °C	4 2.5		9	
ts t <sub>f</sub>	RESISTIVE LOAD Storage Time Fall Time	$V_{CC} = 400 \text{ V}$ $I_{C} = 3 \text{ A}$ $I_{B1} = 1 \text{ A}$ $I_{B2} = -1.5 \text{ A}$		1.8 200	2.7 300	μs ns
ts t <sub>f</sub>	INDUCTIVE LOAD Storage Time Fall Time			2.7 350		μs ns
VF	Diode Forward Voltage	I <sub>F</sub> = 3 A			2.5	V

<sup>\*</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

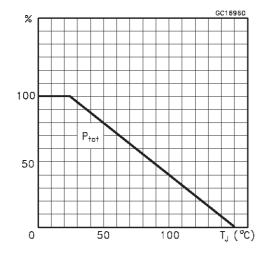
#### Safe Operating Area



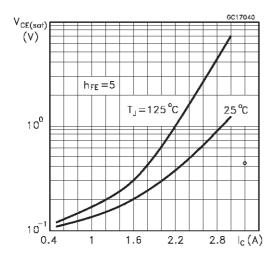
#### Thermal Impedance



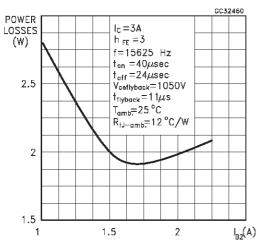
#### **Derating Curve**



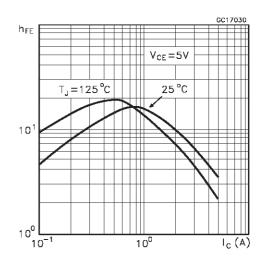
#### Collector Emitter Saturation Voltage



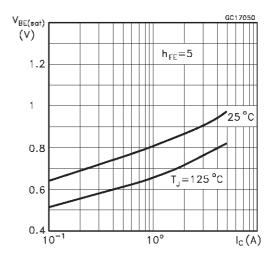
#### Power Losses at 16 KHz



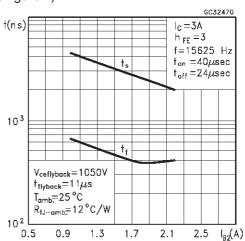
#### DC Current Gain



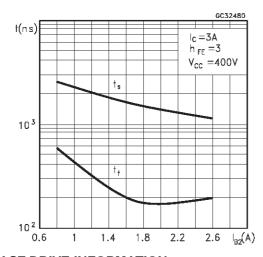
#### Base Emitter Saturation Voltage



# Switching Time Inductive Load at 16KHz (see figure 2)







#### **BASE DRIVE INFORMATION**

In order to saturate the power switch and reduce conduction losses, adequate direct base current  $I_{B1}$  has to be provided for the lowest gain  $h_{FE}$  at 100  $^{\circ}$ C (line scan phase). On the other hand, negative base current  $I_{B2}$  must be provided to turn off the power transistor (retrace phase).

Most of the dissipation, in the deflection application, occurs at switch-off. Therefore it is essential to determine the value of  $I_{\rm B2}$  which minimizes power losses, fall time  $t_{\rm f}$  and, consequently,  $T_{\rm j}$ . A new set of curves have been defined to give total power losses,  $t_{\rm s}$  and  $t_{\rm f}$  as a function of  $I_{\rm B2}$  at 16 KHz scanning frequencies the optimum negative drive. The test circuit is illustrated in fig. 1.

Inductance  $L_1$  serves to control the slope of the negative base current  $I_{B2}$  to recombine the excess carrier in the collector when base current is still present, this would avoid any tailing phenomenon in the collector current.

The values of L and C are calculated from the following equations:

$$\frac{1}{2}L(I_C)^2 = \frac{1}{2}C(V_{CEfly})^2$$
$$\omega = 2\pi f = \frac{1}{\sqrt{LC}}$$

Where I<sub>C</sub>= operating collector current, V<sub>CEfly</sub>= flyback voltage, f= frequency of oscillation during retrace.

Figure 1: Inductive Load Switching Test Circuits.

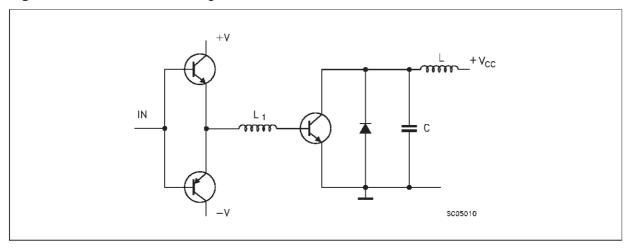
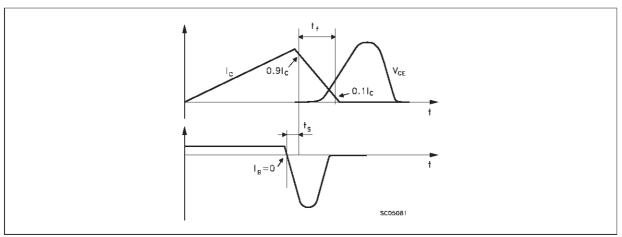
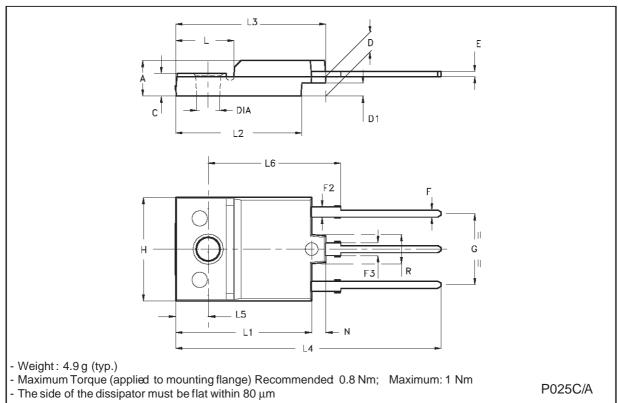


Figure 2: Switching Waveforms in a Deflection Circuit



#### **ISOWATT218 MECHANICAL DATA**

DIM	mm					
DIM.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	5.35		5.65	0.211		0.222
С	3.30		3.80	0.130		0.150
D	2.90		3.10	0.114		0.122
D1	1.88		2.08	0.074		0.082
E	0.75		0.95	0.030		0.037
F	1.05		1.25	0.041		0.049
F2	1.50		1.70	0.059		0.067
F3	1.90		2.10	0.075		0.083
G	10.80		11.20	0.425		0.441
Н	15.80		16.20	0.622		0.638
L		9			0.354	
L1	20.80		21.20	0.819		0.835
L2	19.10		19.90	0.752		0.783
L3	22.80		23.60	0.898		0.929
L4	40.50		42.50	1.594		1.673
L5	4.85		5.25	0.191		0.207
L6	20.25		20.75	0.797		0.817
N	2.1		2.3	0.083		0.091
R		4.6			0.181	
DIA	3.5		3.7	0.138		0.146



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